

Notice of References Cited	Application/Control No. 09/749,980	Applicant(s)/Patent Under Reexamination LEE, ELAINE	
	Examiner Annette R. Reimers	Art Unit 3733	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,957,971	09-1999	Schwartz, Robert S.	623/1.15
*	C	US-5,510,077	04-1996	Dinh et al.	264/485
*	D	US-4,548,736	10-1985	Muller et al.	516/103
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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